

Features

- 60V/143A,
 $R_{DS(ON)} = 2.8m\Omega(Typ.)@V_{GS}=10V$
 $R_{DS(ON)} = 3.6m\Omega(Typ.)@V_{GS}=4.5V$
- Excellent $Q_G \times R_{DS(on)}$ product(FOM)
- SGT Technology
- 100% Avalanche Tested

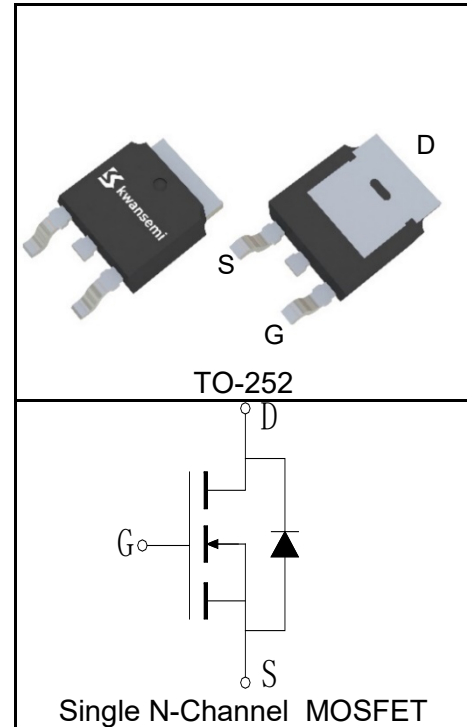
Applications

- DC-DC Converters and Off-line UPS
- Synchronous Rectification



Halogen-Free

Pin Description



Absolute Maximum Ratings

Symbol	Parameter		Rating	Unit
Common Ratings (T _C =25°C Unless Otherwise Noted)				
V _{DSS}	Drain-Source Voltage		60	V
V _{GSS}	Gate-Source Voltage		±20	
T _{Jmax}	Maximum Junction Temperature		175	°C
T _J ,T _{STG}	Operating and Storage Temperature Range		-55 to 175	°C
I _S	Diode Continuous Forward Current	T _C =25°C	143	A
Mounted on Large Heat Sink				
I _{DP} ^①	Pulse Drain Current	T _C =25°C	572	A
I _D ^②	Continuous Drain Current(V _{GS} =10V)	T _C =25°C	143	A
		T _C =100°C	101	
P _D	Maximum Power Dissipation	T _C =25°C	125	W
		T _C =100°C	62	
R _{θJC}	Thermal Resistance-Junction to Case		1.2	°C/W
R _{θJA} ^③	Thermal Resistance-Junction to Ambient		100	°C/W
Drain-Source Avalanche Ratings				
E _{AS} ^④	Avalanche Energy, Single Pulsed		552	mJ

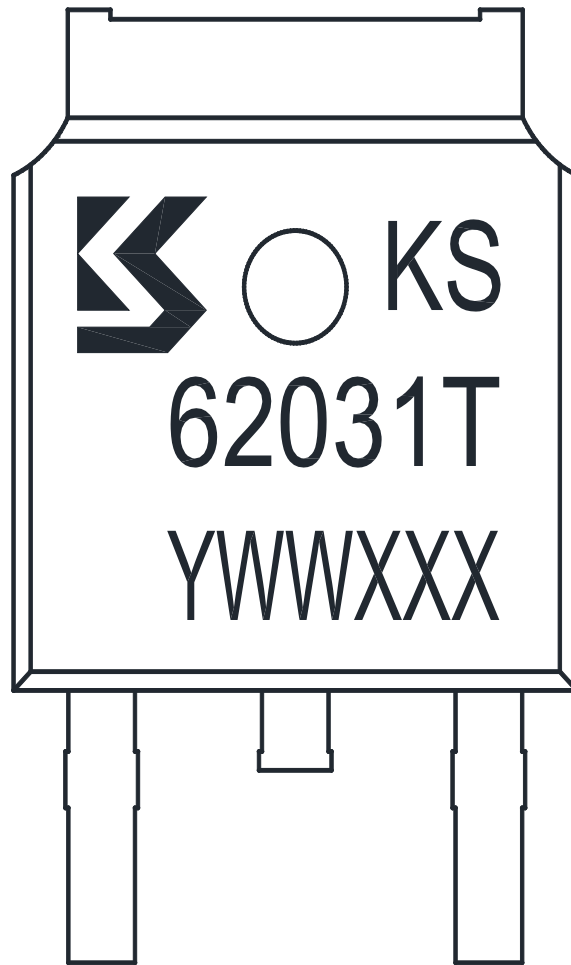
Electrical Characteristics ($T_C=25^{\circ}\text{C}$ Unless Otherwise Noted)

Symbol	Parameter	Test Condition	Rating			Unit
			Min.	Typ.	Max.	
Static Characteristics						
BV _{DSS}	Drain-Source Breakdown Voltage	V _{GS} =0V, I _{DS} =250μA	60			V
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} =60V, V _{GS} =0V			1	μA
			T _J =125°C		30	
V _{GS(th)}	Gate Threshold Voltage	V _{DS} =V _{GS} , I _{DS} =250μA	1.2	1.7	2.3	V
I _{GSS}	Gate Leakage Current	V _{GS} =±20V, V _{DS} =0V			±100	nA
R _{DS(ON)} ^⑤	Drain-Source On-state Resistance	V _{GS} =10V, I _{DS} =20A		2.8	3.5	mΩ
		V _{GS} =4.5V, I _{DS} =15A		3.6	4.8	mΩ
Diode Characteristics						
V _{SD} ^⑤	Diode Forward Voltage	I _{SD} =20A, V _{GS} =0V		0.8	1.2	V
t _{rr}	Reverse Recovery Time	I _{SD} =20A, dI _{SD} /dt=100A/μs		33		ns
Q _{rr}	Reverse Recovery Charge			36		nC
Dynamic Characteristics ^⑥						
R _G	Gate Resistance	V _{GS} =0V, V _{DS} =0V, F=1MHz		2.5		Ω
C _{iss}	Input Capacitance	V _{GS} =0V, V _{DS} =30V, Frequency=200KHz		3400		pF
C _{oss}	Output Capacitance			915		
C _{rss}	Reverse Transfer Capacitance			30		
t _{d(ON)}	Turn-on Delay Time	V _{DD} =30V, I _{DS} =20A, V _{GEN} =10V, R _G =3Ω		17		ns
t _r	Turn-on Rise Time			41		
t _{d(OFF)}	Turn-off Delay Time			29		
t _f	Turn-off Fall Time			14		
Gate Charge Characteristics ^⑥						
Q _g	Total Gate Charge	V _{DS} =30V, V _{GS} =10V, I _{DS} =20A		52		nC
Q _{gs}	Gate-Source Charge			8.2		
Q _{gd}	Gate-Drain Charge			8.5		

- Notes:
- ① Pulse width limited by safe operating area.
 - ② Calculated continuous current based on maximum allowable junction temperature. The package limitation current is 60A.
 - ③ When mounted on 1 inch square copper board, $t \leq 10\text{sec}$. The value in any given application depends on the user's specific board design.
 - ④ Limited by T_{Jmax} , Starting $T_J = 25^{\circ}\text{C}$, $I_{ASmax} = 47A$, $L=0.5\text{mH}$, $V_{DD} = 48V$, $R_G = 25\Omega$, $V_{GS}=10V$. Part not recommended for use above this value. 100% Final Test at $I_{AS}=32A$, $L=0.5\text{mH}$.
 - ⑤ Pulse test; Pulse width $\leq 300\mu s$, duty cycle $\leq 2\%$.
 - ⑥ Guaranteed by design, not subject to production testing.

Ordering and Marking Information

Device	Package	Packaging	Quantity	Reel Size	Tape width
KS62031DAT	TO-252	Tape&Reel	2500	13"	16mm

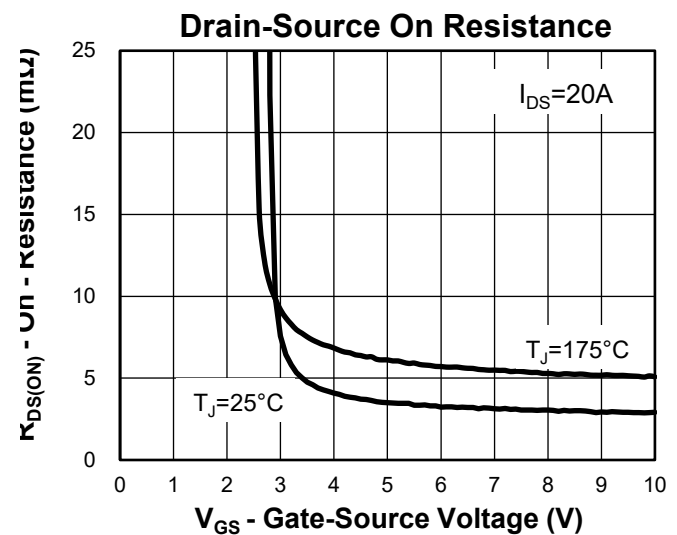
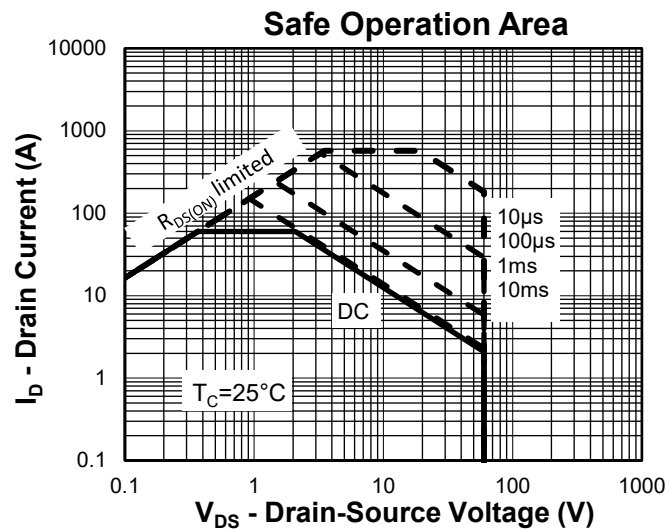
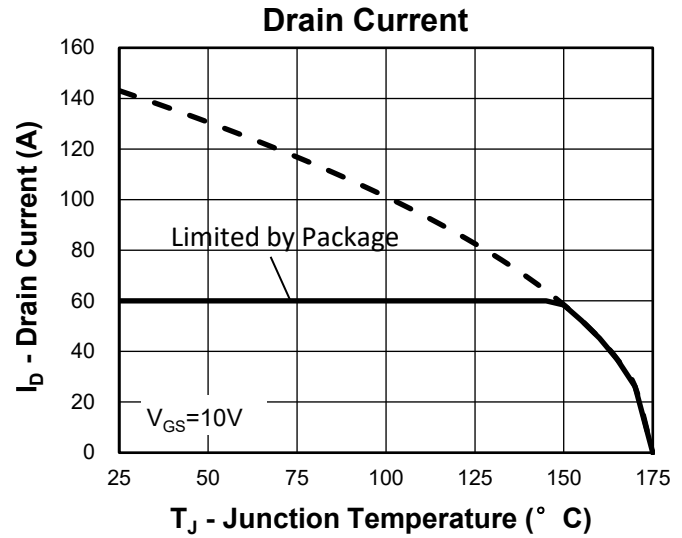
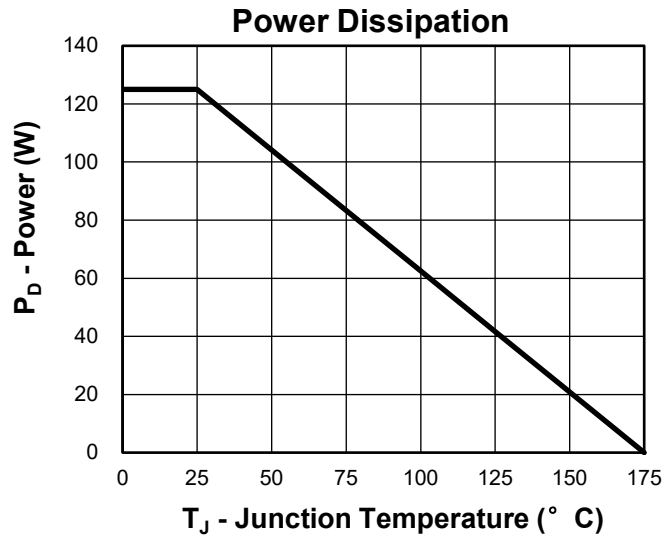


1st Line: Kwansemi LOGO, Kwansemi Code(KS)

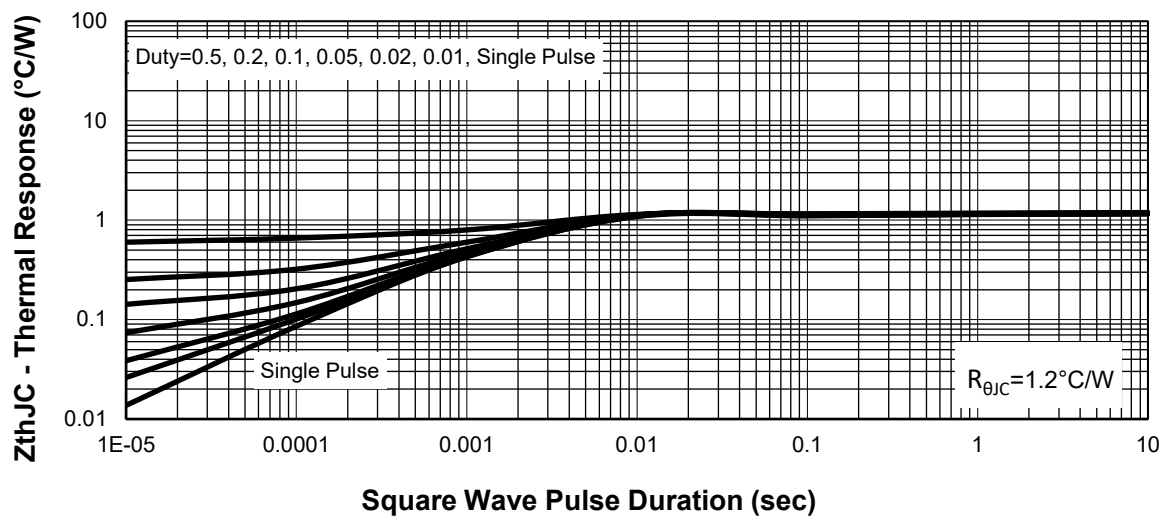
2nd Line: Part Number(62031T)

3rd Line: Lot Number(YWWXXX)

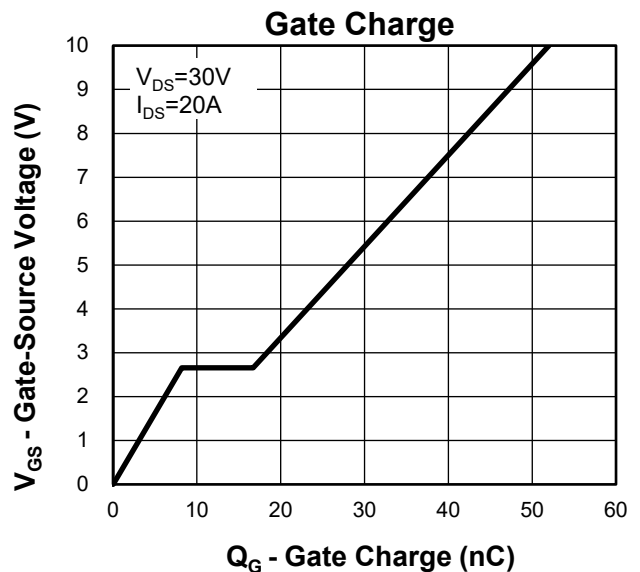
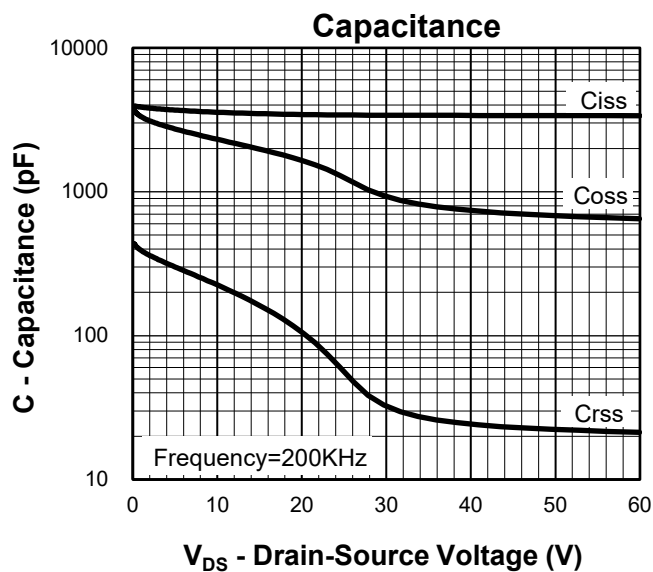
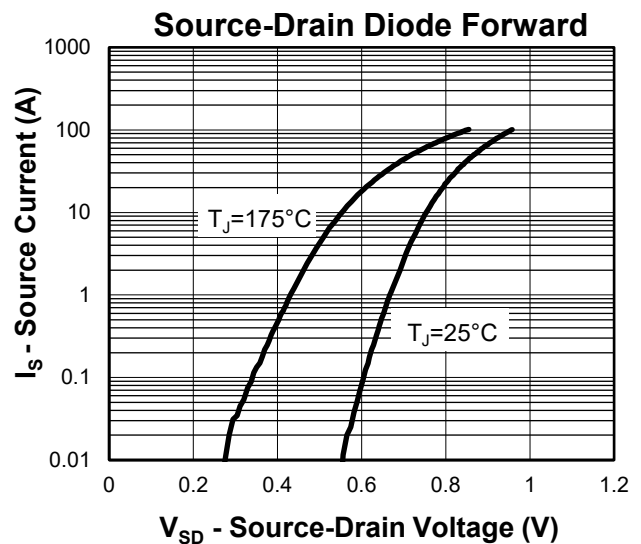
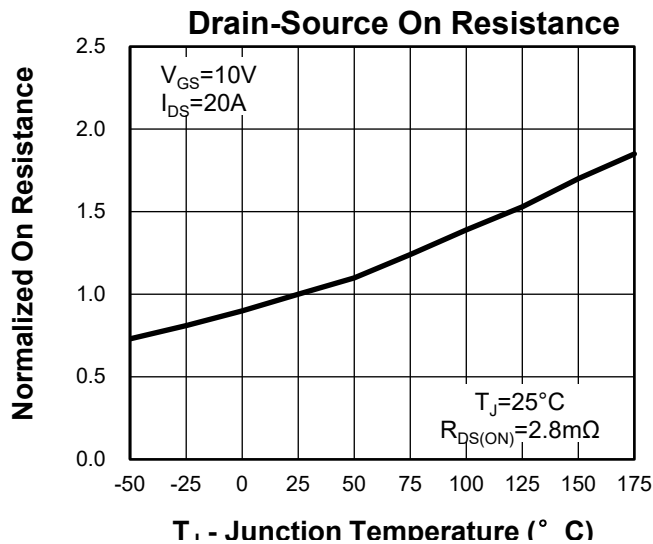
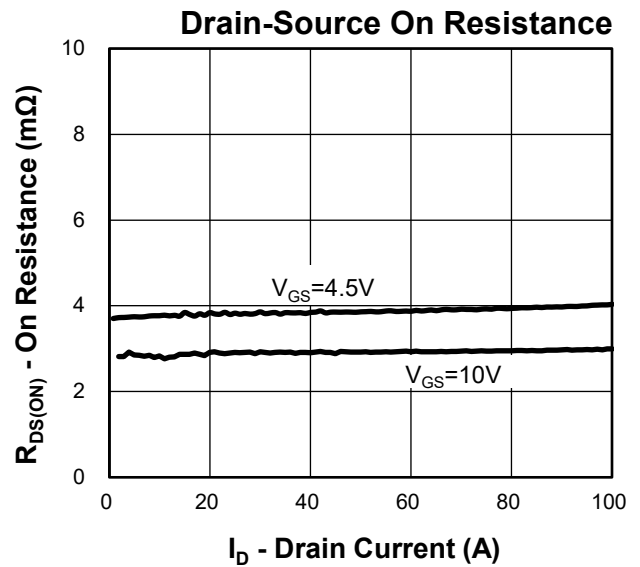
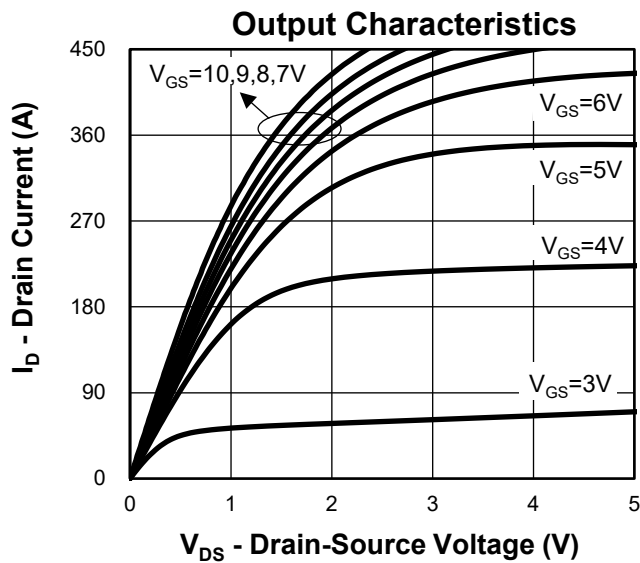
Typical Characteristics



Thermal Transient Impedance

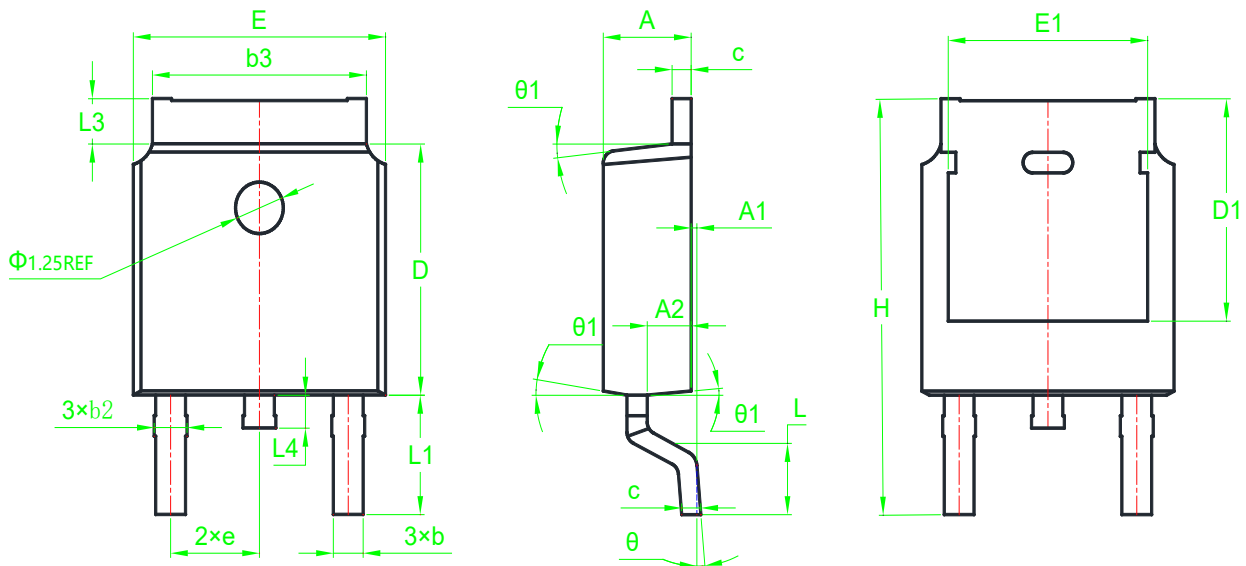


Typical Characteristics



Package Information

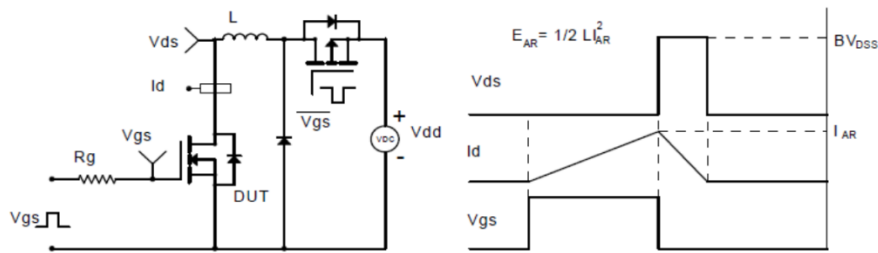
TO-252



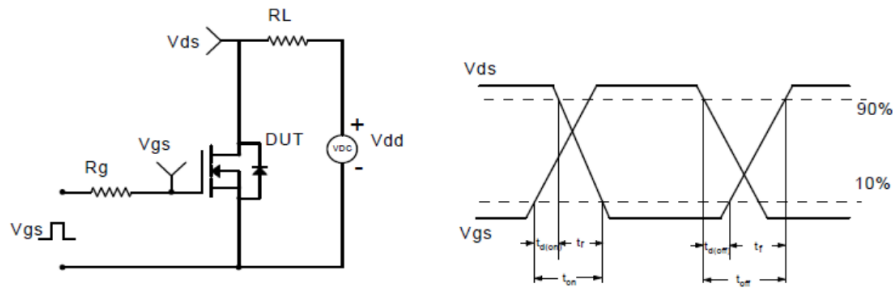
SYMBOL	MM			INCH			SYMBOL	MM			INCH		
	MIN	NOM	MAX	MIN	NOM	MAX		MIN	NOM	MAX	MIN	NOM	MAX
A	2.20	2.30	2.38	0.087	0.091	0.094	E	6.40	6.60	6.70	0.252	0.260	0.264
A1	0.00	*	0.15	0.000	*	0.006	E1	4.55	*	5.15	0.179	*	0.203
A2	0.90	1.00	1.10	0.035	0.039	0.043	H	9.60	10.10	10.40	0.378	0.398	0.409
b	0.65	0.75	0.85	0.026	0.030	0.033	L	1.40	1.50	1.70	0.055	0.059	0.067
b2	0.72	*	0.90	0.028	*	0.035	L1	2.90REF			0.114REF		
b3	5.13	5.33	5.46	0.202	0.210	0.215	L3	0.90	*	1.25	0.035	*	0.049
c	0.47	0.51	0.54	0.019	0.020	0.021	L4	0.60	*	1.00	0.024	*	0.039
D	6.00	6.10	6.20	0.236	0.240	0.244	θ	0°	*	10°	0°	*	10°
D1	5.25	5.35	5.60	0.207	0.211	0.220	θ1	5°	*	9°	5°	*	9°
e	2.286BSC			0.090BSC									

Note: Dimensions do not inclusive burrs and mold flash.

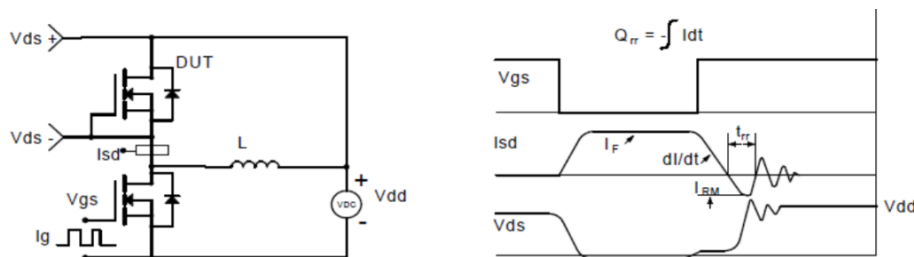
Avalanche Test Circuit and Waveforms



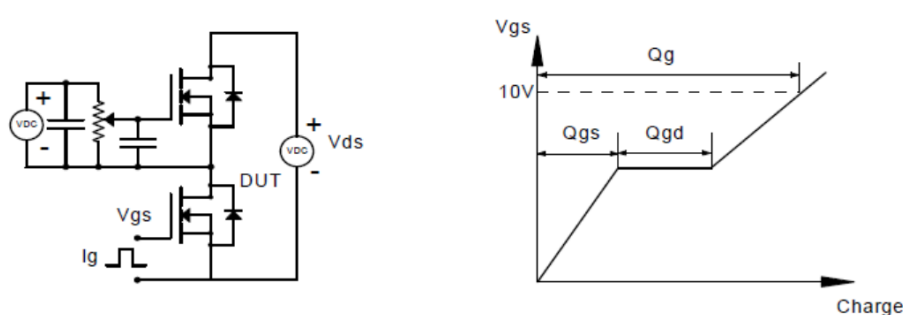
Switching Time Test Circuit and Waveforms



Diode Recovery Test Circuit and Waveforms



Gate Charge Test Circuit and Waveform



Customer Service

Kwansemi Semiconductor Co.,Ltd

Email:Sales@kwansemi.com

Web:www.kwansemi.com

DISCLAIMER:

Kwansemi reserves the right to change the specifications and circuitry without notice at any time. The Products are not designed for use in hostile environments, including, without limitation, aircraft, nuclear power generation, medical appliances, and devices or systems in which malfunction of any Product can reasonably be expected to result in a personal injury. Seller's customers using or selling Seller's products for use in such applications do so at their own risk and agree to fully defend and indemnify Seller.